Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/666,205	STAMPFER ET AL.	
Examiner	Art Unit	
Yong D. Pak	1652	

SEARCHED				
Class	Subclass	Date	Examiner	
435	190	5/31/2006	. ҮР	
435	440	5/31/2006	YP	
435	4	5/31/2006	YP	
435	6	5/31/2006	YP	
435	15	5/31/2006	YP	
435	18	5/31/2006	YP	
435	25	5/31/2006	YP	
435	69.1	5/31/2006	YP	
435	71.1	5/31/2006	YP	
435	252.3	5/31/2006	ΥP	
435	320.1	5/31/2006	YP	
536	23.2	5/31/2006	YP	
536	23.7	5/31/2006	ΥP	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	 			

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
stic: seq id no:3 and 48	5/31/2006	ΥP
stn/east: see search history	5/31/2006	ΥP
Inventor search	5/31/2006	ΥP